



FCC Radio Test Report

FCC ID: XMR202106EG91AUX

This report concerns: Original Grant

Project No. : 2009H029B
Equipment : LTE Module
Brand Name : Quectel
Test Model : EG91-AUX

Series Model : N/A

Applicant: Quectel Wireless Solutions Company Limited

Address : Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin

Road, Minhang District, Shanghai, China 200233.

Manufacturer: Quectel Wireless Solutions Co., Ltd.

Address : Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin

Road, Minhang District, Shanghai, China 200233.

Date of Receipt : Apr. 16, 2021

Date of Test : Apr. 16, 2021 ~ May 10, 2021

Issued Date : Jun. 01, 2021

Report Version : R01

Test Sample: Engineering Sample No.: SH2021041698 for Radiated;

SH2020091134 for Conducted; SH2020091134-2 for adapter.

Standard(s) : 47 CFR FCC Part 22 Subpart H

47 CFR FCC Part 2

ANSI/TIA/EIA-603-E-2016

FCC KDB 971168 D01 Power Meas License Digital Systems v03r01

The above equipment has been tested and found compliance with the requirement of the relative standards by BTL Inc.

Maker Qi

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ssac

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Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective.

Please note that the measurement uncertainty is provided for informational purpose only and is not use in determining the Pass/Fail results.



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REPORT ISSUED HISTORY

Report Version	Description	Issued Date
R00	This report is base on the reference report (Report No.: BTL-FCCP-1-2009H029A/FCC ID: XMR202106EG95AUX) for worst case spot check (Except the output power) and record. Please refer to the "Differences Brief Description" in section 1.4 and other data in the reference report.	May 27, 2021
R01	Revised report to address TCB's comments.	Jun. 01, 2021



1. SUMMARY OF TEST RESULTS

Test procedures according to the technical standard(s):

FCC Part 22 Subpart H & Part 2			
Standard(s) Section	Test Item	Judgment	Remark
2.1046 22.913(a)	Effective Radiated Power	PASS	
2.1049	Occupied Bandwidth	PASS	
2.1051 22.917(a)	Conducted Spurious Emissions	PASS	
2.1053 22.917(a)	Radiated Spurious Emissions	PASS	
22.917(a)	Band Edge Measurements	PASS	
-	Peak To Average Ratio	PASS	
2.1055 22.355	Frequency Stability	PASS	

Note:

For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".



1.1 TEST FACILITY

The test facilities used to collect the test data in this report is at the location of No. 29, Jintang Road, Tangzhen Industry Park, Pudong New Area, Shanghai 201210, China.

BTL's Test Firm Registration Number for FCC: 476765

BTL's Designation Number for FCC: CN1241

1.2 MEASUREMENT UNCERTAINTY

The measurement uncertainty figures shall be calculated according the methods described in the ETSI TR 100 028 and shall correspond to an expansion factor (coverage factor) k=1.96 or k=2(which provide confidence levels of respectively 90% and 95.45% in the case where the distributions characterizing the actual measurement uncertainties are normal (Gaussian)).

Measurement Uncertainty for a Level of Confidence of 95 %, U=2xUc(y).

The BTL measurement uncertainty as below table:

A. Radiated Measurement:

Test Site	Method	Measurement Frequency Range		U,(dB)
		9KHz ~ 30MHz	V	3.79
SH-CB01 CISPR	9KHz ~ 30MHz		Н	3.57
	CICDD	30MHz ~ 200MHz	V	4.12
	30MHz ~ 200MHz	Н	3.20	
		200MHz ~ 1,000MHz	V	3.12
		200MHz ~ 1,000MHz	Н	3.18

Test Site	Method	Measurement Frequency Range	U,(dB)
SH-CB01	CISPR	1GHz ~ 6GHz	4.40
(3m)	CISER	6GHz ~ 18GHz	4.86

Test Site	Method	Measurement Frequency Range	U,(dB)
SH-CB01 CISPR		18 ~ 26.5 GHz	3.64
(3m)	CIOPR	26.5 ~ 40 GHz	3.78

Note: Unless specifically mentioned, the uncertainty of measurement has not been taken into account to declare the compliance or non-compliance to the specification.

1.3 TEST ENVIRONMENT CONDITIONS

Test Item	Temperature	Humidity	Test Voltage	Tested By
Output Power & ERP	26°C	55%	DC 3.8V	Danny Dang
Occupied Bandwidth	26°C	55%	DC 3.8V	Danny Dang
Conducted Spurious Emissions	26°C	55%	DC 3.8V	Danny Dang
Radiated Spurious Emissions	24°C	58%	DC 3.8V	Forest Li
Band Edge	26°C	55%	DC 3.8V	Danny Dang
Peak to Average Ratio	26°C	55%	DC 3.8V	Danny Dang
Frequency Stability	N	ormal and Ex	ktreme	Danny Dang



1.4 TEST DATA RE-USE SUMMARY

Differences Brief Description:

- 1.EG95-AUX and EG91-AUX share the same hardware design, the layout is the same.
- 2.Both EG95-AUX and EG91-AUX built-in BB are MDM9207, but EG95-AUX is MDM9207-0 which support up to cat 4, and EG91-AUX is MDM9207-1 which support up to cat 1.
- 3.EG95-AUX supports diversity antenna, while EG91-AUX does not support LTE and WCDMA diversity. All the others are same.



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Equipment	LTE Module		
Brand Name	Quectel		
Test Model	EG91-AUX		
Series Model	N/A		
Model Difference(s)	N/A		
Software Version	EG91AUXGAR08A02M1G		
Hardware Version	R1.0		
Power Source	DC Voltage supplied from AC/DC adapter(supplied from AC/DC adapter)	port unit)	
Power Rating	Supply voltage:3.3-4.3V, Typical supply voltage	e:3.8V	
Antenna Type	Dipole		
71	GSM850		
Antenna Gain	WCDMA V	2.53 dBi	
	LTE Band 5		
	GSM	GMSK	
	GPRS	GMSK	
	EDGE	GMSK, 8PSK	
Modulation Type	WCDMA	UL: QPSK	
	WODNA	DL: QPSK,16QAM	
	LTE	UL: QPSK,16QAM	
	LIL	DL: QPSK,16QAM,64QAM	
	EDGE/GSM/GPRS	824.2MHz ~ 848.8MHz	
Operation Frequency	WCDMA Band V	826.4MHz ~ 846.6MHz	
	LTE Band 5 (Channel Bandwidth: 1.4MHz)	824.7 MHz ~ 848.3 MHz	
	LTE Band 5 (Channel Bandwidth: 3MHz)	825.5 MHz ~ 847.5 MHz	
	LTE Band 5 (Channel Bandwidth: 5MHz)	826.5 MHz ~ 846.5 MHz	
	LTE Band 5 (Channel Bandwidth: 10MHz)	829.0 MHz ~ 844.0 MHz	



	GSM	GMSK	33.16	dBm
	GPRS	GMSK	32.97	dBm
	EDGE	8PSK	26.87	dBm
	WCDMA	QPSK	23.86	dBm
	LTE Day 15 (Obay and Day 1 1/1/1 4 40411)	QPSK	23.13	dBm
Max. ERP Power	LTE Band 5 (Channel Bandwidth: 1.4MHz)	16QAM	22.67	dBm
	LTE Band 5 (Channel Bandwidth: 3MHz)	QPSK	23.26	dBm
		16QAM	22.60	dBm
		QPSK	23.16	dBm
	LTE Band 5 (Channel Bandwidth: 5MHz)	16QAM	21.98	dBm
	LTE Day 15 (Obay and Day 1 Sittle 40MIL)	QPSK	23.30	dBm
	LTE Band 5 (Channel Bandwidth: 10MHz)	16QAM	22.18	dBm

Note:

- 1. For a more detailed features description, please refer to the manufacturer's specifications or the user's manual.
- 2. WCDMA (UL: QPSK; DL: QPSK) mode was found to be the worst case and recorded.



2.2 DESCRIPTION OF TEST MODES AND TEST CONDITION

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, XYZ axis and antenna ports

The worst case was found when positioned on X-plane for EIRP and X-axis for radiated emission.

Following channel(s) was (were) selected for the final test as listed below:

GSM MODE				
Test Item	Available Channel	Tested Channel	Mode	
ERP	128 to 251	128, 190, 251	GSM,GPRS, EDGE	
Output Power	128 to 251	128, 190, 251	GSM,GPRS, EDGE	
Occupied Bandwidth	128 to 251	128, 190, 251	GSM, EDGE	
Condcudeted Emission	128 to 251	190	GSM, EDGE	
Radiated Emission	128 to 251	190	EDGE	
Band Edge	128 to 251	128, 251	GSM, EDGE	
Peak to Average Ratio	128 to 251	128, 190, 251	GSM, EDGE	
Frequency Stability	128 to 251	190	GSM	

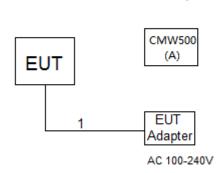
WCDMA MODE				
Test Item	Available Channel	Tested Channel	Mode	
ERP	4132 to 4233	4132, 4182, 4233	WCDMA, HSDPA, HSUPA	
Output Power	4132 to 4233	4132, 4182, 4233	WCDMA, HSDPA, HSUPA	
Conducted Emission	4132 to 4233	4182	WCDMA	
Radiated Emission	4132 to 4233	4182	WCDMA	
Band Edge	4132 to 4233	4132, 4233	WCDMA	
Peak to Average Ratio	4132 to 4233	4132, 4182, 4233	WCDMA	
Frequency Stability	4132 to 4233	4182	WCDMA	



		LTE	BAND 5		
Test Item	Available Channel	Tested Channel	Channel Bandwidth	Modulation	Mode
	20407 to 20643	20407, 20525, 20643	1.4MHz	QPSK, 16QAM	1RB/3RB/6RB
Output Power	20415 to 20635	20415, 20525, 20635	3MHz	QPSK, 16QAM	1RB/8RB/15RB
& ERP	20425 to 20625	20425, 20525, 20625	5MHz	QPSK, 16QAM	1RB/12RB/25RB
	20450 to 20600	20450, 20525, 20600	10MHz	QPSK, 16QAM	1RB/25RB/50RB
	20407 to 20643	20407, 20525, 20643	1.4MHz	QPSK, 16QAM	6 RB
Occupied	20415 to 20635	20415, 20525, 20635	3MHz	QPSK, 16QAM	15 RB
Bandwidth	20425 to 20625	20425, 20525, 20625	5MHz	QPSK, 16QAM	25 RB
	20450 to 20600	20450, 20525, 20600	10MHz	QPSK, 16QAM	50 RB
Conducted	20407 to 20643	20525	1.4MHz	QPSK	1 RB
Emission	20425 to 20625	20525	5MHz	QPSK	1 RB
21111001011	20450 to 20600	20525	10MHz	QPSK	1 RB
Radiated	20407 to 20643	20525	1.4MHz	QPSK	1 RB
Emission	20425 to 20625	20525	5MHz	QPSK	1 RB
LITIISSIOTI	20450 to 20600	20525	10MHz	QPSK	1 RB
	20407 to 20643	20407	1.4MHz	QPSK	1 RB 6 RB
		20643	1.4MHz	QPSK	1 RB 6 RB
	20415 to 20635	20415	3MHz	QPSK	1 RB 15 RB
Band Edge		20635	3MHz	QPSK	1 RB 15 RB
Dana Lage	20425 to 20625	20425	5MHz	QPSK	1 RB 25 RB
	20420 to 20020	20625	5MHz	QPSK	1 RB 25 RB
	20450 to 20600	20450	10MHz	QPSK	1 RB 50 RB
	20400 to 20000	20600	10MHz	QPSK	1 RB 50 RB
	20407 to 20643	20407, 20525, 20643	1.4MHz	QPSK, 16QAM	1 RB
Peak To Average	20415 to 20635	20415, 20525, 20635	3MHz	QPSK, 16QAM	1 RB
Ratio	20425 to 20625	20425, 20525, 20625	5MHz	QPSK, 16QAM	1 RB
	20450 to 20600	20450, 20525, 20600	10MHz	QPSK, 16QAM	1 RB
	20407 to 20643	20525	1.4MHz	QPSK	1 RB
Frequency	20415 to 20635	20525	3MHz	QPSK	1 RB
Stability	20425 to 20625	20525	5MHz	QPSK	1 RB
	20450 to 20600	20525	10MHz	QPSK	1 RB



2.3 BLOCK DIGRAM SHOWING THE CONFIGURATIONOFSYSTEMTESTED



3.4 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	Series No.
Α	CMW500	N/A	N/A	131463

Item	Cable Type	Shielded Type	Ferrite Core	Length
1	DC Cable	NO	NO	1.5m



3. TEST RESULT

3.1 OUTPUT POWER MEASUREMENT

3.1.1 LIMIT

Mobile / Portable station are limited to 7 watts e.r.p.

3.1.2 TEST PROCEDURE

EIRP/ERP:

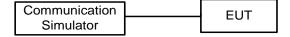
 EIRP= Output Power +Antenan gain ERP power= EIPR power-2.15dBi.

Output Power:

The EUT was set up for the maximum power with GPRS, EDGE, WCDMA and LTE link data modulation and link up with simulator. Set the EUT to transmit under low, middle and high channel and record the power level shown on simulator.

3.1.3 TEST SETUP LAYOUT

Output Power Measurement



3.1.4 TEST DEVIATION

No deviation

3.1.5 TEST RESULTS

Please refer to the Appendix A.

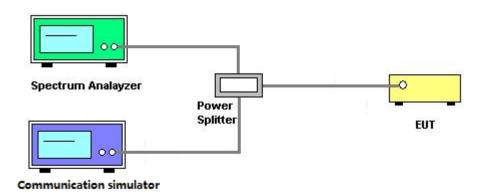


3.2 OCCUPIED BANDWIDTH MEASUREMENT

3.2.1 TEST PROCEDURE

The EUT makes a call to the communication simulator. All measurements were done at low, middle and high operational frequency range. The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth and 26dB bandwidth.

3.2.2 TEST SETUP LAYOUT



3.2.3 TEST DEVIATION

No deviation

3.2.4 TEST RESULTS

Please refer to the Appendix B.



3.3 CONDUCTED EMISSIONS MEASUREMENT

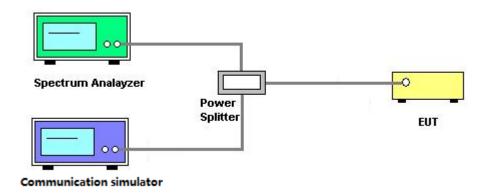
3.3.1 LIMIT

The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB. The emission limit equal to -13dBm.

3.3.2 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 v03r01 Section 6.0.
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- 3. The band edges of low and high channels for the highest RF powers were measured. Set RBW>=1% EBW in the 1MHz band immediately outside and adjacent to the band edge.
- 4. Set spectrum analyzer with RMS detector.
- 5. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

3.3.3 TEST SETUP LAYOUT



3.3.4 TEST DEVIATION

No deviation

3.3.5 TEST RESULTS

Please refer to the Appendix C.



3.4 RADIATED EMISSIONS MEASUREMENT

3.4.1 LIMIT

The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB. The emission limit equal to -13dBm.

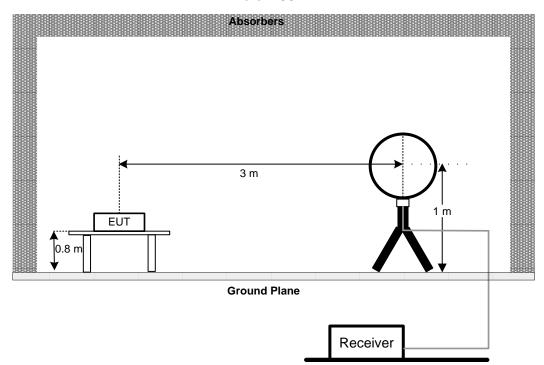
3.4.2 TEST PROCEDURES

- 1. Substitution method is used for E.I.R.P measurement. In the semi-anechoic chamber, EUT placed on the 0.8m height of Turn Table, rotated the table around 360 degrees to search the maximum radiation power and receiver antenna shall be rotated vertical and horizontal polarization and moved height from 1m to 4m to find the maximum polar radiated power. The "Read Value" is the spectrum reading the maximum power value.
- 2. The substitution horn antenna is substituted for EUT at the same position and signals generator export the CW signal to the substitution antenna via a TX cable. Rotated the Turn Table and moved receiving antenna to find the maximum radiation power. Adjust output power level of S.G to get a Value of spectrum reading equal to "Read Value" of step a. Record the power level of S.G
- 3. EIRP = Output power level of S.G TX cable loss + Antenna gain of substitution horn.
- 4. E.R.P power can be calculated form E.I.R.P power by subtracting the gain of dipole, E.R.P power = E.I.P.R power 2.15dBi.
- 5. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 1MHz/3MHz.

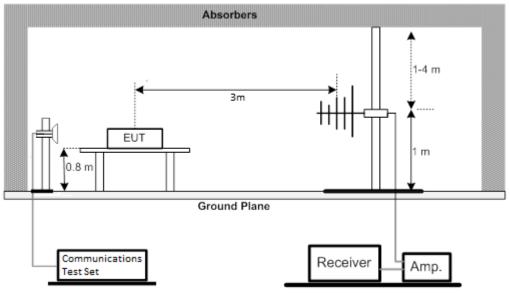


3.4.3 TEST SETUP LAYOUT

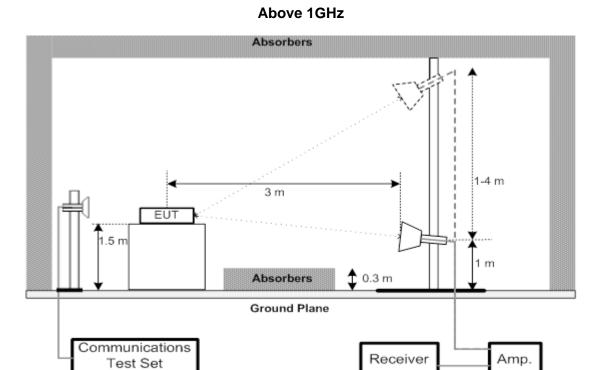
Below 30MHz



30MHz to 1GHz







3.4.4 TEST DEVIATION

No deviation

3.4.5 TEST RESULTS (9KHZ TO 30MHZ)

Please refer to the Appendix D.

3.4.6 TEST RESULTS (30MHZ TO 1000MHZ)

Please refer to the Appendix E.

3.4.7 TEST RESULTS (ABOVE 1000MHZ)

Please refer to the Appendix F.



3.5 BAND EDGE MEASUREMENT

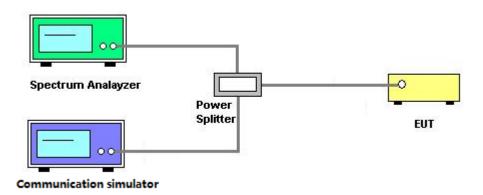
3.5.1 LIMIT

A Power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB. In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

3.5.2 TEST PROCEDURES

- 1. All measurements were done at low and high operational frequency range.
- 2. The center frequency of spectrum is the band edge frequency and span is 1.5MHz. RB of the spectrum is 3kHz and VB of the spectrum is 10kHz (GPRS/EDGE).
- 3. The center frequency of spectrum is the band edge frequency and span is 10MHz. RB of the spectrum is 100kHz and VB of the spectrum is 300kHz (WCDMA).
- 4. The center frequency of spectrum is the band edge frequency and span is 2MHz. RB of the spectrum is 15kHz and VB of the spectrum is 43kHz (LTE Bandwidth 1.4MHz).
- 5. The center frequency of spectrum is the band edge frequency and span is 2MHz. RB of the spectrum is 30kHz and VB of the spectrum is 91kHz (LTE Bandwidth 3MHz).
- 6. The center frequency of spectrum is the band edge frequency and span is 2MHz. RB of the spectrum is 51kHz and VB of the spectrum is 150kHz (LTE Bandwidth 5MHz).
- 7. The center frequency of spectrum is the band edge frequency and span is 2MHz. RB of the spectrum is 100kHz and VB of the spectrum is 300kHz (LTE Bandwidth 10MHz).
- 8. The center frequency of spectrum is the band edge frequency and span is 2MHz. RB of the spectrum is 150kHz and VB of the spectrum is 470kHz (LTE Bandwidth 15MHz).
- 9. The center frequency of spectrum is the band edge frequency and span is 2MHz. RB of the spectrum is 200kHz and VB of the spectrum is 620kHz (LTE Bandwidth 20MHz).

3.5.3 TEST SETUP LAYOUT



3.5.4 TEST DEVIATION

No deviation

3.5.5 TEST RESULTS

Please refer to the Appendix G.



3.6 PEAK TO AVERAGE RATIO MEASUREMENT

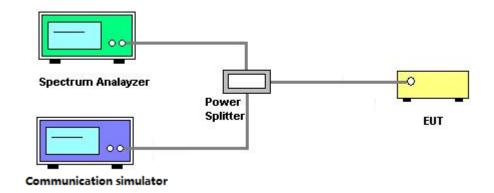
3.6.1 LIMIT

In measuring transmissions in this band using an average power technique, the peak to-average ratio (PAR) of the transmission may not exceed 13 dB.

3.6.2 TEST PROCEDURES

- 1. Set resolution/measurement bandwidth ≥ signal's occupied bandwidth;
- 2. Set the number of counts to a value that stabilizes the measured CCDF curve;
- 3. Record the maximum PAPR level associated with a probability of 0.1%.

3.6.3 TEST SETUP LAYOUT



3.6.4 TEST DEVIATION

No deviation

3.6.5 TEST RESULTS

Please refer to the Appendix H.



3.7 FREQUENCY STABILITY MEASUREMENT

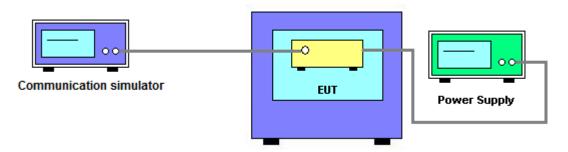
3.7.1 LIMIT

±1.5 ppm is for base and fixed station. ±2.5 ppm is for mobile station.

3.7.2 TEST PROCEDURES

- 1. Device is placed at the oven room. The oven room could control the temperatures and humidity. Power warm up is at least 15 min and power applied should perform before recording frequency error.
- 2. EUT is connected the external power supply to control the DC input power. The test voltage range is from minimum to maximum working voltage. Each step shall be record the frequency error rate.
- 3. The temperature range step is 10 degrees in this test items. All temperature levels shall be hold the ±0.5°C during the measurement testing. The each temperature step shall be at least 0.5 hours, consider the EUT could be test under the stability condition.
- 4. The frequency error was recorded frequency error from the communication simulator.

3.7.3 TEST SETUP LAYOUT



3.7.4 TEST DEVIATION

No deviation

3.7.5 TEST RESULTS

Please refer to the Appendix I.



5. LIST OF MEASUREMENT EQUIPMENTS

	Radiated Emission Measurement(9K-30M)						
Item	Kind of Equipment	Manufacturer	Serial No.	Calibrated until			
1	Loop Antenna	EMCI	EMCI LPA600	275	Apr. 14, 2022		
2	EMI Test Receiver	R&S	ESCI	100082	Mar. 21, 2022		
3	Measurement Software	Farad	EZ-EMC Ver.NB-03A1-01	N/A	N/A		
4	Wideband Radio Communication Test	R&S	CMW500	129246	Aug. 23, 2021		

	Radiated Emission Measurement(30M-1G)						
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until		
1	TRILOG Broadband Antenna	Schwarzbeck	VULB 9168	719	Mar. 26, 2022		
2	Pre-Amplifier	emci	emci EMC9135		Mar. 20, 2022		
3	MXE EMI Receiver	Keysight	N9038A	MY56400088	Mar. 21, 2022		
4	Test Cable	emci	EMC104-SM-SM-7000	170330	Apr. 11, 2022		
5	Test Cable	emci	EMC104-SM-SM-1000	170331	Apr. 11, 2022		
6	Test Cable	emci	EMC104-SM-NM-3500	170621	Apr. 11, 2022		
7	Measurement Software	Farad	EZ-EMC Ver.NB-03A1-01	N/A	N/A		
8	Wideband Radio Communication Test	R&S	CMW500	129246	Aug. 23, 2021		

	Radiated Emission Measurement(1G-18G)						
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until		
1	Double-Ridged Waveguide Horn Antenna	ETS-Lindgren 9120D		00206960	Mar. 26, 2022		
2	Pre-Amplifier	emci	emci EMC012645SE		May. 11, 2021		
3	EXA Spectrum Analyzer	Keysight	N9010A	MY56480545	Mar. 20, 2022		
4	Test Cable	emci	EMC104-SM-SM-7000	170330	Apr. 11, 2022		
5	Test Cable	emci	EMC104-SM-SM-1000	170331	Apr. 11, 2022		
6	Test Cable	emci	EMC104-SM-NM-3500	170621	Apr. 11, 2022		
7	Measurement Software	Farad	EZ-EMC Ver.NB-03A1-01	N/A	N/A		
8	Wideband Radio Communication Test	R&S	CMW500	129246	Aug. 23, 2021		





For WCDMA

	Conducted Emission & Band Edge & Occupied Bandwidth Measurement						
Item	Kind of Equipment	Manufacturer	Manufacturer Type No. Serial No.		Calibrated until		
1	Wideband Radio Communication Test	R&S	CMW500	129246	Aug. 23, 2021		
2	Spectrum Analyzer	R&S	FSP40	100626	May. 06, 2021 May. 05, 2022		
3	EXA Spectrum Analyzer	Keysight	N9010A	MY56480579	Mar. 21, 2022		
4	Power Divider	JUK	PD-2SF-2060	N/A	N/A		

	Frequency Stability Measurement						
Item	Kind of Equipment	Manufacturer	Type No. Serial No.		Calibrated until		
1	Wideband Radio Communication Test	R&S	CMW500	129246	Aug. 23, 2021		
2	Spectrum Analyzer	R&S	FSP40	100626	May. 06, 2021 May. 05, 2022		
3	EXA Spectrum Analyzer	Keysight	N9010A	MY56480579	Mar. 21, 2022		
4	Power Divider	JUK	PD-2SF-2060	N/A	N/A		
5	Temperature And Humidity Box	Blue pand	BPHS-120B	170616454	Aug. 23, 2021		

For LTE

	Conducted Emission & Band Edge & Occupied Bandwidth Measurement						
Item	Kind of Equipment	Manufacturer	Manufacturer Type No. Serial No.		Calibrated until		
1	EXA Spectrum Analyzer	Keysight	N9010A	MY56480579	Mar. 21, 2022		
2	Power Divider	JUK	PD-4SF-2060	N/A	N/A		
3	Wideband Radio Communication Test	R&S	CMW500	129246	Aug. 23, 2021		
4	Spectrum Analyzer	R&S	FSP40	100626	May. 06, 2021 May. 05, 2022		

	Frequency Stability Measurement						
Item	Kind of Equipment	Manufacturer	urer Type No. Serial No.		Calibrated until		
1	EXA Spectrum Analyzer	Keysight	Keysight N9010A		Mar. 21, 2022		
2*	Power Divider	JUK	PD-4SF-2060	N/A	N/A		
3	Wideband Radio Communication Test	R&S	CMW500	129246	Aug. 23, 2021		
4	Spectrum Analyzer	R&S	FSP40	100626	May. 06, 2021 May. 05, 2022		
5	Temperature And Humidity Box	Blue pand	BPHS-120B	170616454	Aug. 23, 2021		

Remark: "N/A" denotes no model name, serial no. or calibration specified.

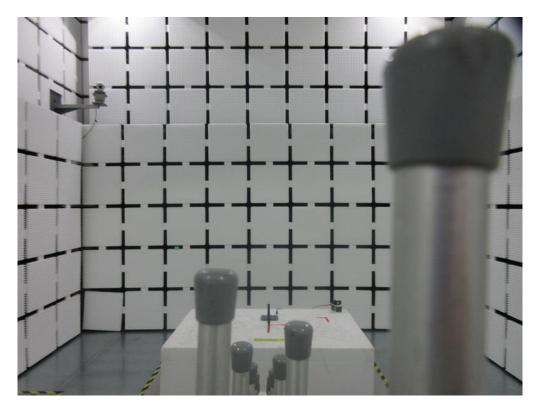
All calibration period of equipment list is one year.

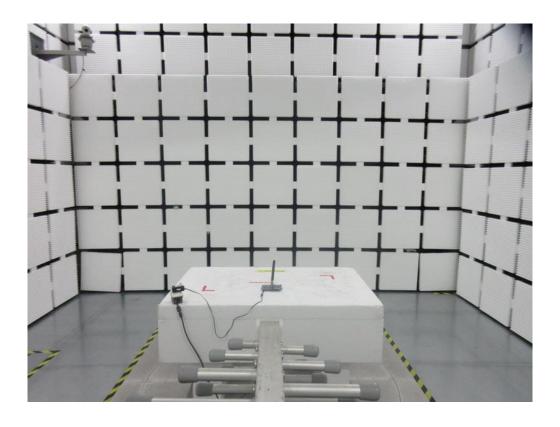


6. EUT TEST PHOTO

Radiated Emissions Test Photos

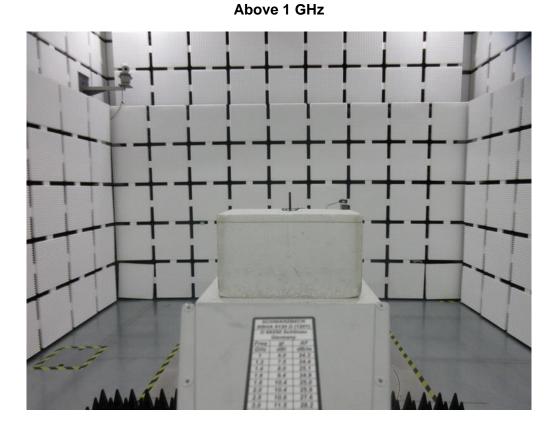
30 MHz to 1000 MHz

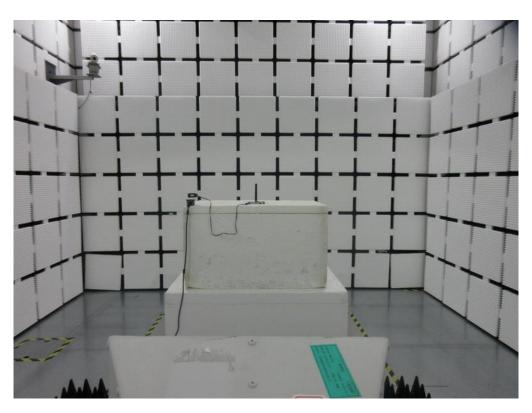






Radiated Emissions Test Photos







APPENDIX A - OUTPUT POWER	



Output Power (dBm):

		Burst Output Power			
GSM850		128CH	190CH	251CH	
		824.2MHz	836.6MHz	848.8MHz	
GSM(GMS	K)	32.68	32.72	32.78	
	1 Tx Slot	32.49	32.56	32.59	
GPRS/EDGE	2 Tx Slot	31.25	31.19	31.22	
(GMSK)	3 Tx Slot	30.12	30.05	30.13	
	4 Tx Slot	28.85	28.78	28.71	
	1 Tx Slot	26.45	26.49	26.36	
EDGE	2 Tx Slot	24.52	24.47	24.43	
(8PSK)	3 Tx Slot	22.67	22.58	22.62	
	4 Tx Slot	21.54	21.52	21.64	

	Band		WCDMA V	
Modulation	Tx Channel	4132CH	4182CH	4233CH
	Frequency	826.4MHz	836.4MHz	846.6MHz
	RMC 12.2K	23.34	23.41	23.38
	RMC 64K	23.44	23.33	23.35
	RMC 144K	23.43	23.34	23.42
	RMC 384K	23.41	23.37	23.48
	HSDPA Subtest-1	22.1	22.05	22.11
	HSDPA Subtest-2	22.16	22.18	22.22
QPSK	HSDPA Subtest-3	22.22	22.21	22.46
	HSDPA Subtest-4	22.1	22.17	22.12
	HSUPA Subtest-1	22.33	22.32	22.29
	HSUPA Subtest-2	22.33	22.38	22.27
	HSUPA Subtest-3	22.32	22.31	22.3
	HSUPA Subtest-4	22.31	22.37	22.33
	HSUPA Subtest-5	22.21	22.25	22.25



				Low CH	Mid CH	High CH
LTE Band / BW	Modulation	RB C:	RB Officet	20407CH	20525CH	20643CH
		Size	Offset	824.7MHz	836.5MHz	848.3MHz
		1	0	22.70	22.58	22.64
		1	2	22.69	22.75	22.55
		1	5	22.64	22.61	22.71
	QPSK	3	0	22.66	22.69	22.51
		3	1	22.72	22.64	22.73
		3	2	22.65	22.75	22.70
E / 1 ANA		6	0	21.60	21.56	21.50
5 / 1.4M		1	0	21.57	21.56	21.53
		1	2	21.75	21.43	21.83
	16QAM	1	5	21.50	21.32	21.65
		3	0	21.40	21.38	22.12
		3	1	21.56	21.42	22.14
		3	2	21.68	21.61	22.29
		6	0	20.58	20.42	20.62

LTE Band / BW	Modulation	RB	RB	Low CH 20415CH	Mid CH 20525CH	High CH 20635CH
LIE Ballu / BVV	Modulation	Size	Offset	825.5MHz	836.5MHz	847.5MHz
		1	0	22.74	22.62	22.69
		1	7	22.86	22.69	22.65
		1	14	22.77	22.69	22.88
	QPSK	8	0	21.57	21.64	21.68
		8	4	21.61	21.72	21.52
		8	7	21.53	21.70	21.48
E / 2M		15	0	21.65	21.76	21.59
5 / 3M		1	0	21.95	21.39	21.97
		1	7	22.00	21.75	22.14
	16QAM	1	14	22.13	21.49	22.22
		8	0	21.25	20.59	21.05
		8	4	21.11	20.85	20.99
		8	7	20.95	20.82	20.98
		15	0	20.90	20.72	20.72



				Low CH	Mid CH	High CH
LTE Band / BW	Modulation	RB C:	RB Officet	20425CH	20525CH	20625CH
		Size	Offset	826.5MHz	836.5MHz	846.5MHz
		1	0	22.70	22.69	22.64
		1	13	22.76	22.61	22.73
		1	24	22.78	22.66	22.52
	QPSK	12	0	21.58	21.56	21.53
		12	6	21.62	21.71	21.69
		12	11	21.64	21.70	21.70
5 / 5M		25	0	21.71	21.61	21.68
3 / SIVI		1	0	21.21	21.59	21.32
		1	13	21.03	21.56	21.16
	16QAM	1	24	21.09	21.60	21.32
		12	0	20.68	20.52	20.42
		12	6	20.73	20.49	20.57
		12	11	20.66	20.58	20.49
		25	0	20.87	20.71	20.56

		D.D.	55	Low CH	Mid CH	High CH
LTE Band / BW	Modulation	RB Size	RB Offset	20450CH	20525CH	20600CH
		Size	Oliset	829.0MHz	836.5MHz	844.0MHz
		1	0	22.81	22.82	22.69
		1	25	22.92	22.55	22.85
		1	49	22.91	22.76	22.69
	QPSK	25	0	21.74	21.73	21.76
		25	13	21.73	21.68	21.65
		25	25	21.72	21.61	21.73
E / 10M		50	0	21.73	21.75	21.64
5 / 10M		1	0	21.60	21.80	21.64
		1	25	21.72	21.56	21.50
	16QAM	1	49	21.63	21.56	21.65
		25	0	21.53	20.84	21.73
		25	13	21.71	20.80	21.80
		25	25	21.72	20.93	21.69
		50	0	20.76	20.72	20.65



ERP Power (dBm):

		ERP Power				
GSM850)	128CH	190CH	251CH		
		824.2MHz	836.6MHz	848.8MHz		
GSM(GMS	SK)	33.06	33.10	33.16		
	1 Tx Slot	32.87	32.94	32.97		
GPRS/EDGE	2 Tx Slot	31.63	31.57	31.60		
(GMSK)	3 Tx Slot	30.50	30.43	30.51		
	4 Tx Slot	29.23	29.16	29.09		
	1 Tx Slot	26.83	26.87	26.74		
EDGE (8PSK)	2 Tx Slot	24.90	24.85	24.81		
	3 Tx Slot	23.05	22.96	23.00		
	4 Tx Slot	21.92	21.90	22.02		

	Band		WCDMA V	
Modulation	Tx Channel	4132CH	4182CH	4233CH
	Frequency	826.4MHz	836.4MHz	846.6MHz
	RMC 12.2K	23.72	23.79	23.76
	RMC 64K	23.82	23.71	23.73
	RMC 144K	23.81	23.72	23.80
	RMC 384K	23.79	23.75	23.86
	HSDPA Subtest-1	22.48	22.43	22.49
	HSDPA Subtest-2	22.54	22.56	22.60
QPSK	HSDPA Subtest-3	22.60	22.59	22.84
	HSDPA Subtest-4	22.48	22.55	22.50
	HSUPA Subtest-1	22.71	22.70	22.67
	HSUPA Subtest-2	22.71	22.76	22.65
	HSUPA Subtest-3	22.70	22.69	22.68
	HSUPA Subtest-4	22.69	22.75	22.71
	HSUPA Subtest-5	22.59	22.63	22.63



				Low CH	Mid CH	High CH
LTE Band / BW	Modulation	RB Size	RB Offset	20407CH	20525CH	20643CH
		Size	Oliset	824.7MHz	836.5MHz	848.3MHz
		1	0	23.08	22.96	23.02
		1	2	23.07	23.13	22.93
		1	5	23.02	22.99	23.09
	QPSK	3	0	23.04	23.07	22.89
		3	1	23.10	23.02	23.11
		3	2	23.03	23.13	23.08
5 / 1.4M		6	0	21.98	21.94	21.88
5 / 1.4W		1	0	21.95	21.94	21.91
		1	2	22.13	21.81	22.21
	16QAM	1	5	21.88	21.70	22.03
		3	0	21.78	21.76	22.50
		3	1	21.94	21.80	22.52
		3	2	22.06	21.99	22.67
		6	0	20.96	20.80	21.00

				1		
		RB	RB	Low CH	Mid CH	High CH
LTE Band / BW	Modulation		Offset	20415CH	20525CH	20635CH
		Size	Oliset	825.5MHz	836.5MHz	847.5MHz
		1	0	23.12	23.00	23.07
		1	7	23.24	23.07	23.03
		1	14	23.15	23.07	23.26
	QPSK	8	0	21.95	22.02	22.06
		8	4	21.99	22.10	21.90
		8	7	21.91	22.08	21.86
E / 2N4		15	0	22.03	22.14	21.97
5 / 3M		1	0	22.33	21.77	22.35
		1	7	22.38	22.13	22.52
	16QAM	1	14	22.51	21.87	22.60
		8	0	21.63	20.97	21.43
		8	4	21.49	21.23	21.37
		8	7	21.33	21.20	21.36
		15	0	21.28	21.10	21.10



	1		1	T	1	
		DD	RB	Low CH	Mid CH	High CH
LTE Band / BW	Modulation	RB Size	Offset	20425CH	20525CH	20625CH
		Size	Oliset	826.5MHz	836.5MHz	846.5MHz
		1	0	23.08	23.07	23.02
		1	13	23.14	22.99	23.11
		1	24	23.16	23.04	22.90
	QPSK	12	0	21.96	21.94	21.91
		12	6	22.00	22.09	22.07
		12	11	22.02	22.08	22.08
5 / 5M		25	0	22.09	21.99	22.06
S / SIVI		1	0	21.59	21.97	21.70
		1	13	21.41	21.94	21.54
	16QAM	1	24	21.47	21.98	21.70
		12	0	21.06	20.90	20.80
		12	6	21.11	20.87	20.95
		12	11	21.04	20.96	20.87
		25	0	21.25	21.09	20.94

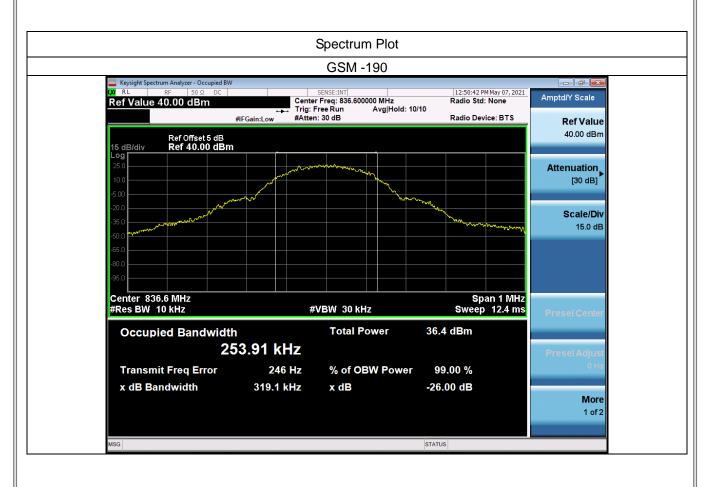
				1		
		RB	RB	Low CH	Mid CH	High CH
LTE Band / BW	Modulation		Offset	20450CH	20525CH	20600CH
		Size	Oliset	829.0MHz	836.5MHz	844.0MHz
		1	0	23.19	23.20	23.07
		1	25	23.30	22.93	23.23
		1	49	23.29	23.14	23.07
	QPSK	25	0	22.12	22.11	22.14
		25	13	22.11	22.06	22.03
		25	25	22.10	21.99	22.11
E / 10M		50	0	22.11	22.13	22.02
5 / 10M		1	0	21.98	22.18	22.02
		1	25	22.10	21.94	21.88
	16QAM	1	49	22.01	21.94	22.03
		25	0	21.91	21.22	22.11
		25	13	22.09	21.18	22.18
		25	25	22.10	21.31	22.07
		50	0	21.14	21.10	21.03



APPENDIX B - OCCUPIED BANDWIDTH

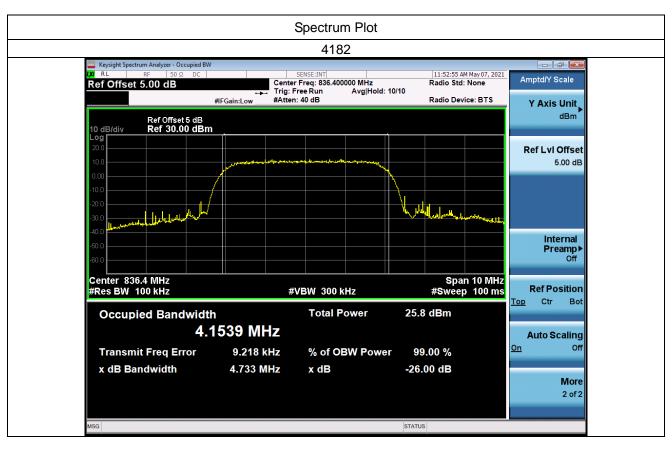


GSM850									
GSM									
GMSK									
Channel	Frequency (MHz)	99% Occupied Bandwidth (MHz)	Channel	Frequency (MHz)	26dB Bandwidth (MHz)				
190	836.6	0.2539	190	836.6	0.3191				



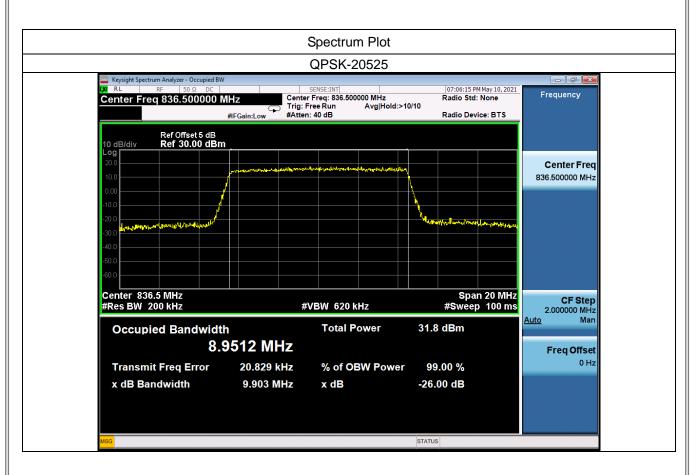


WCDMA Band V									
QPSK									
Channel	Frequency (MHz)	99% Occupied Bandwidth (MHz)	Channel	Frequency (MHz)	26dB Bandwidth (MHz)				
4182	836.4	4.1539	4182	836.4	4.733				





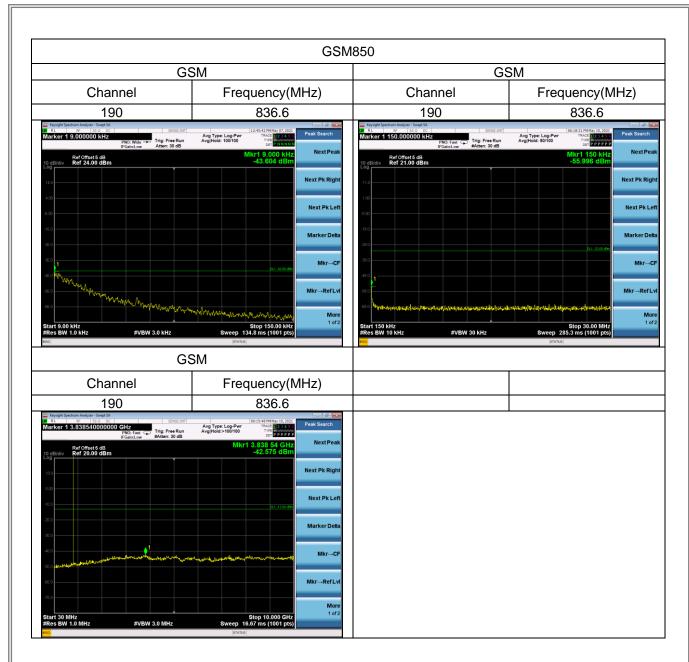
	LTE Band 5_10M										
	QPSK										
Channel	Frequency (MHz)	99% Occupied Bandwidth (MHz)	Channel	Frequency (MHz)	26dB Bandwidth (MHz)						
20525	836.5	8.9512	836.5	9.903							



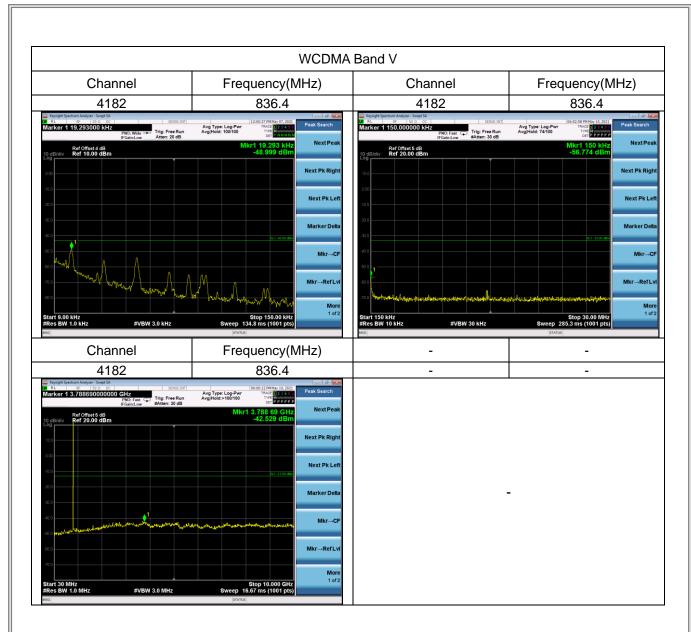


APPENDIX C - CONDUCTED EMISSIONS	

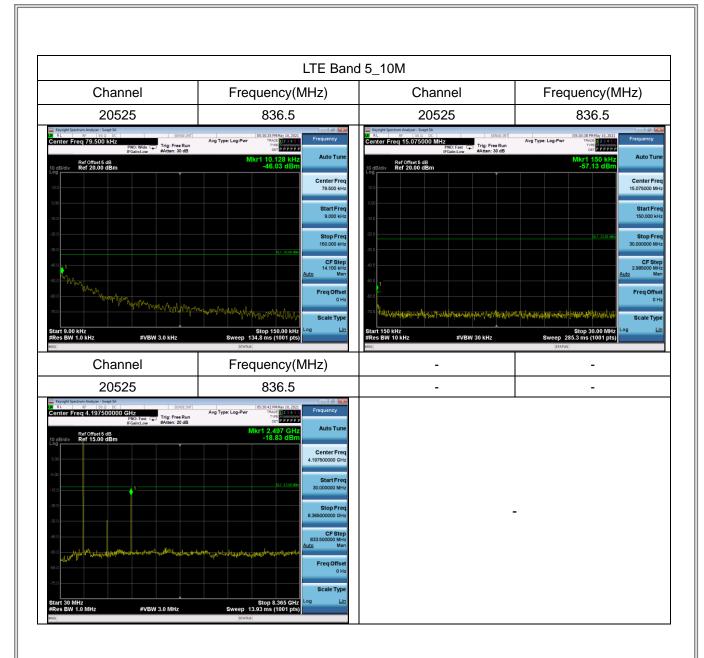














APPENDIX D - RADIATED EMISSION (9KHZ TO 30MHZ)

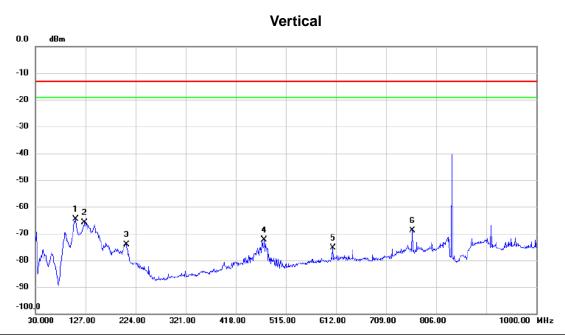
Note: Below 30MHz, The measured value have enough margin over 20dB than the limit, therefore they are not reported.



APPENDIX E - RADIATED EMISSION (30MHZ TO 1GHZ)	



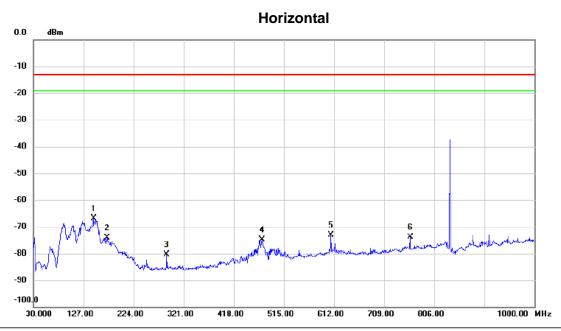
Test Mode: GSM850



No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1	*	108.5700	-66.98	2.24	-64.74	-13.00	-51.74	RMS	
2		125.5450	-67.33	1.53	-65.80	-13.00	-52.80	RMS	
3		206.0550	-70.58	-3.56	-74.14	-13.00	-61.14	RMS	
4		473.2900	-73.49	1.13	-72.36	-13.00	-59.36	RMS	
5		606.1800	-79.62	4.15	-75.47	-13.00	-62.47	RMS	
6		759.4400	-74.62	5.73	-68.89	-13.00	-55.89	RMS	



Test Mode: GSM850



	No.	Mk.	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
_			MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
_	1	*	146.8850	-63.74	-3.06	-66.80	-13.00	-53.80	RMS	
	2		172.5900	-70.64	-3.45	-74.09	-13.00	-61.09	RMS	
	3		288.0200	-79.66	-0.82	-80.48	-13.00	-67.48	RMS	
_	4		472.8050	-76.01	1.21	-74.80	-13.00	-61.80	RMS	
	5		606.1800	-77.29	4.10	-73.19	-13.00	-60.19	RMS	
	6		759.4400	-79.48	5.69	-73.79	-13.00	-60.79	RMS	
_										



30.000

127.00

224.00

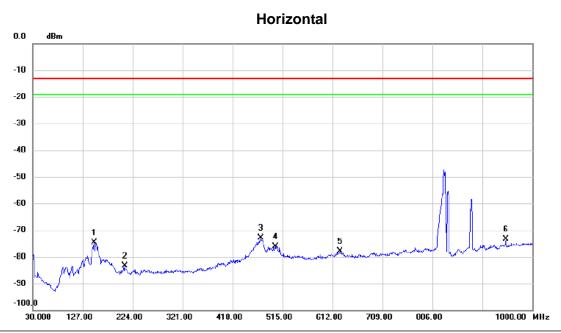
Test Mode: WCDMA Band V_TX Mode

Vertical 0.0 dBm -10 -20 -30 -40 -50 -60 -70 -80 -90 -100. 515.00 806.00 1000.00 MHz 321.00 418.00 612.00 709.00

No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		134.7600	-74.56	1.14	-73.42	-13.00	-60.42	RMS	
2		207.5100	-71.31	-3.55	-74.86	-13.00	-61.86	RMS	
3		240.9750	-79.75	-3.33	-83.08	-13.00	-70.08	RMS	
4	*	475.7150	-74.13	1.15	-72.98	-13.00	-59.98	RMS	
5		626.0650	-82.55	4.12	-78.43	-13.00	-65.43	RMS	
6		946.1650	-81.49	7.17	-74.32	-13.00	-61.32	RMS	



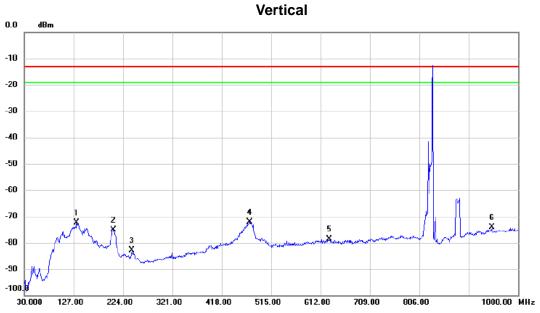
Test Mode: WCDMA Band V_TX Mode



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		149.3100	-71.67	-2.87	-74.54	-13.00	-61.54	RMS	
2		208.9650	-79.72	-3.70	-83.42	-13.00	-70.42	RMS	
3	*	472.8050	-74.15	1.21	-72.94	-13.00	-59.94	RMS	
4		500.9350	-77.70	1.64	-76.06	-13.00	-63.06	RMS	
5		627.0350	-81.89	4.09	-77.80	-13.00	-64.80	RMS	
6		948.5900	-80.47	7.08	-73.39	-13.00	-60.39	RMS	



Test Mode: LTE Band 5_TX Mode_10M



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		133.3050	-73.54	1.20	-72.34	-13.00	-59.34	RMS	
2		205.5700	-71.60	-3.56	-75.16	-13.00	-62.16	RMS	
3		240.9750	-79.45	-3.33	-82.78	-13.00	-69.78	RMS	
4	*	473.2900	-73.17	1.13	-72.04	-13.00	-59.04	RMS	
5		628.9750	-82.85	4.11	-78.74	-13.00	-65.74	RMS	
6		948.5900	-81.40	7.22	-74.18	-13.00	-61.18	RMS	

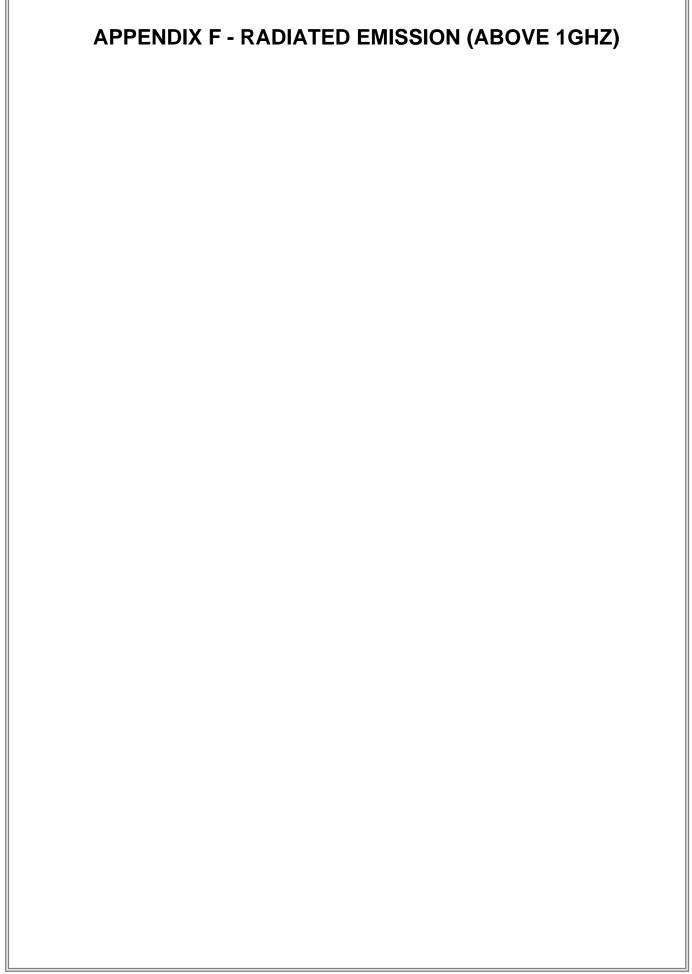


Test Mode: LTE Band 5_TX Mode_10M

Horizontal dBm 0.0 -10 -20 -30 -40 -50 -60 -70 -80 -90 -100.0 1000.00 MHz 127.00 321.00 418.00 612.00

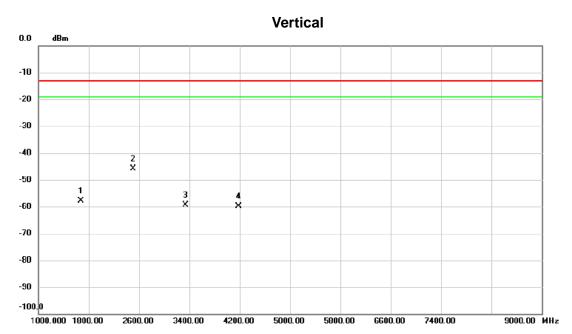
No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		153.6750	-72.61	-2.91	-75.52	-13.00	-62.52	RMS	
2		208.9650	-79.43	-3.70	-83.13	-13.00	-70.13	RMS	
3	*	473.2900	-74.10	1.21	-72.89	-13.00	-59.89	RMS	
4		629.9450	-81.66	4.09	-77.57	-13.00	-64.57	RMS	
5		754.1050	-82.68	5.59	-77.09	-13.00	-64.09	RMS	
6		948.5900	-81.88	7.08	-74.80	-13.00	-61.80	RMS	







Test Mode: GSM850_



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		1672.800	-51.38	-6.52	-57.90	-13.00	-44.90	RMS	
2	*	2509.200	-42.69	-3.17	-45.86	-13.00	-32.86	RMS	
3		3345.600	-58.15	-1.18	-59.33	-13.00	-46.33	RMS	
4		4182.400	-62.21	2.23	-59.98	-13.00	-46.98	RMS	

9000.00 MHz



-100.0

1000.000 1800.00

2600.00

3400.00

4200.00

Test Mode: GSM850_

No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		1672.800	-56.20	-7.10	-63.30	-13.00	-50.30	RMS	
2	*	2509.200	-43.45	-3.81	-47.26	-13.00	-34.26	RMS	
3		3345.600	-60.79	-1.49	-62.28	-13.00	-49.28	RMS	
4		4182.000	-63.32	1.82	-61.50	-13.00	-48.50	RMS	

5000.00

5800.00

6600.00

7400.00

9000.00 MHz



Test Mode: WCDMA Band V_

2600.00

3400.00

4200.00

1000.000 1800.00

No.	Mk	c. Freq.	Reading Level		Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		1671.200	-55.85	-6.52	-62.37	-13.00	-49.37	RMS	
2	*	2512.400	-57.35	-3.17	-60.52	-13.00	-47.52	RMS	
3		3348.400	-61.30	-1.19	-62.49	-13.00	-49.49	RMS	

5000.00

5800.00

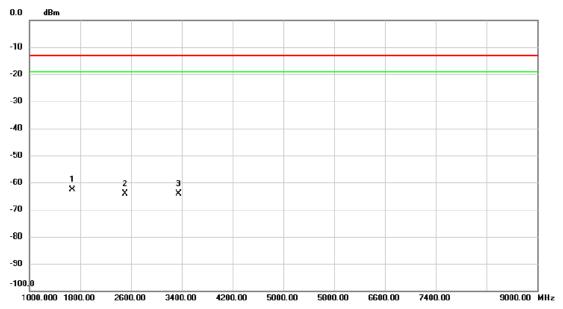
6600.00

7400.00



Test Mode: WCDMA Band V_

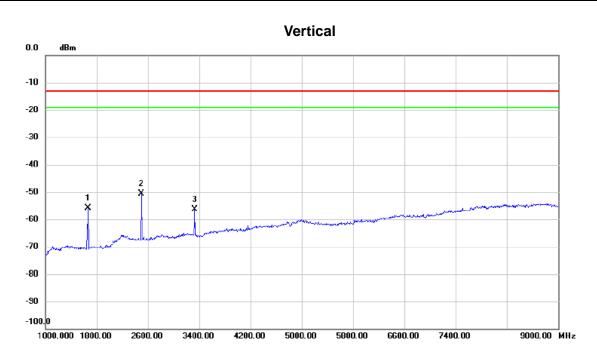
Horizontal



No.	M	c. Freq.			Measure- ment		Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1	*	1674.400	-55.57	-7.09	-62.66	-13.00	-49.66	RMS	
2		2511.600	-60.21	-3.81	-64.02	-13.00	-51.02	RMS	
3		3349.600	-62.64	-1.50	-64.14	-13.00	-51.14	RMS	



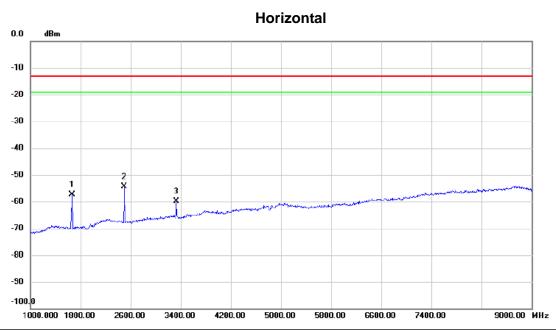
Test Mode: LTE Band 5_TX CH20525_10M



	No.	Mk	. Freq.		Correct Factor	Measure- ment	Limit	Margin		
_			MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
_	1		1664.000	-49.39	-6.53	-55.92	-13.00	-42.92	RMS	
_	2	*	2496.400	-47.36	-3.19	-50.55	-13.00	-37.55	RMS	
_	3		3328.400	-55.32	-1.12	-56.44	-13.00	-43.44	RMS	



Test Mode: LTE Band 5_TX CH20525_10M

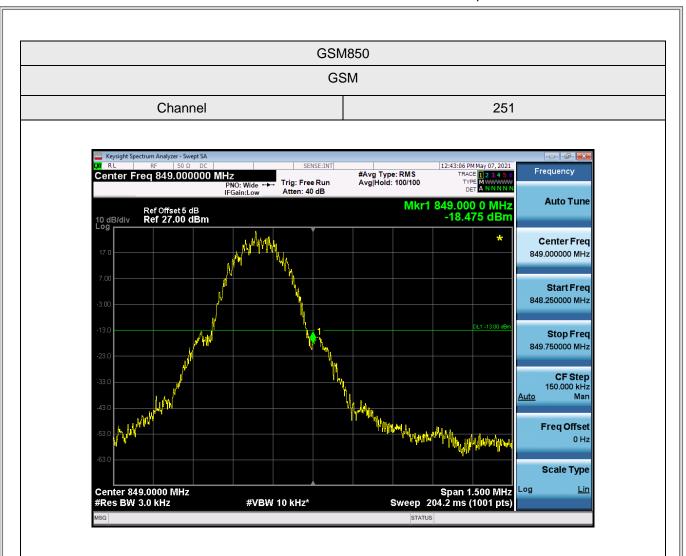


No.	M	c. Freq.	Reading Level		Measure- ment	Limit	Margin		
		MHz	dBm	dB	dBm	dBm	dB	Detector	Comment
1		1664.400	-50.36	-7.11	-57.47	-13.00	-44.47	RMS	
2	*	2496.400	-50.60	-3.80	-54.40	-13.00	-41.40	RMS	
3		3328.000	-58.48	-1.47	-59.95	-13.00	-46.95	RMS	

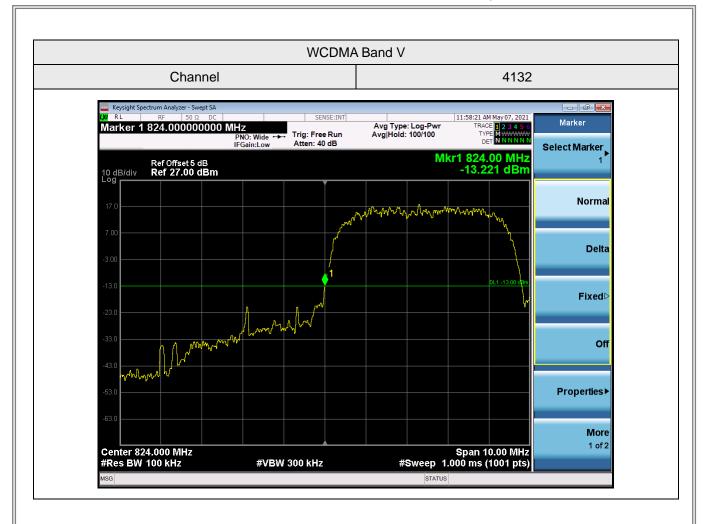


APPENDIX G - BAND EDGE

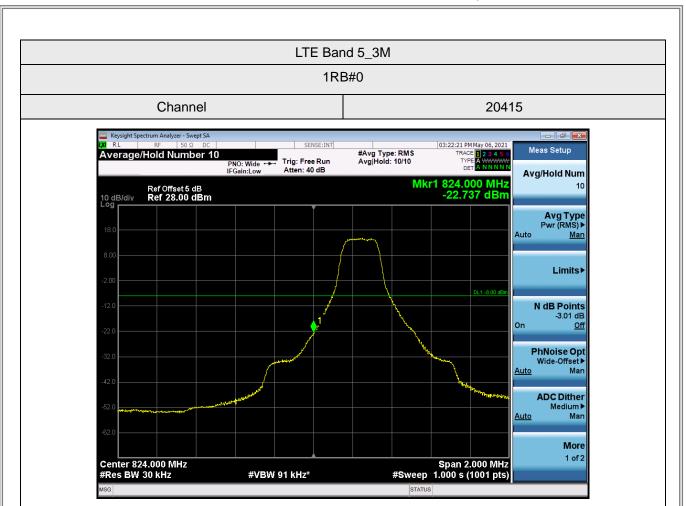








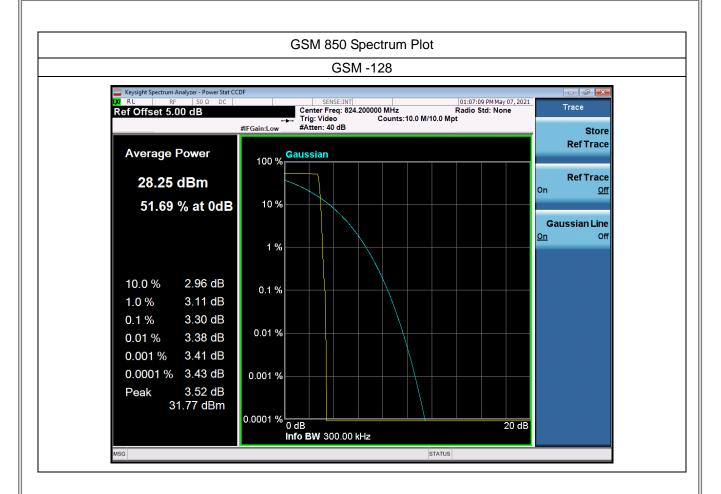




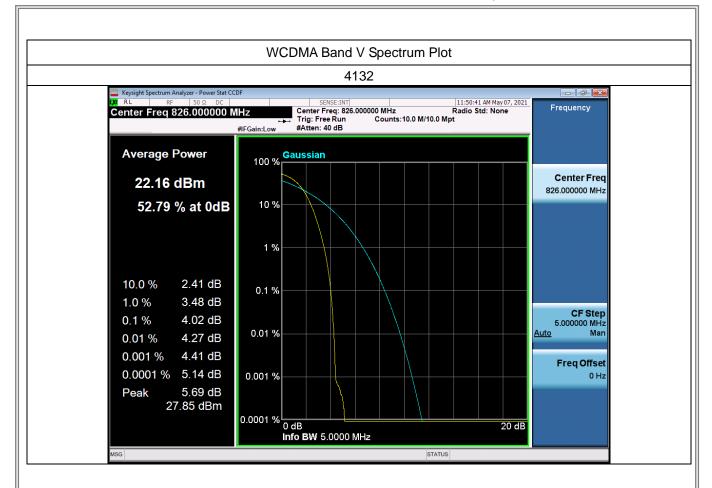


APPENDIX H - PEAK TO AVERAGE RATIO

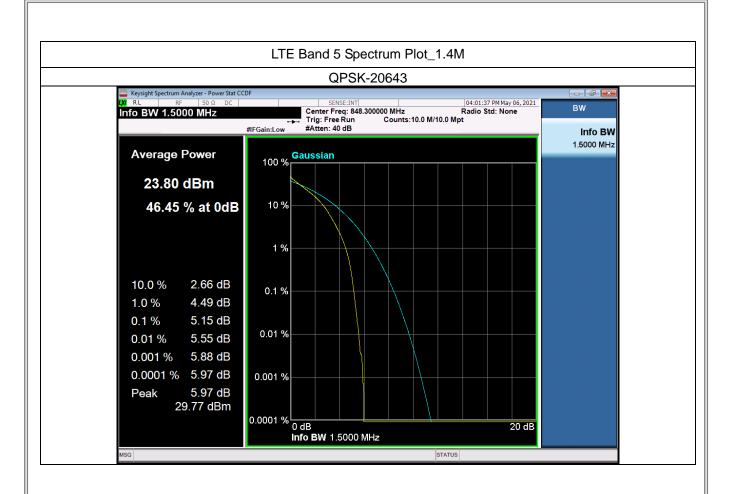














APPENDIX I - FREQUENCY STABILITY





Test Mode: GSM850_CH190

Temperature vs. Frequency Stabiility

Temperature(°C)	Frequency Error (Hz)	Frequency Error (ppm)	Limit(ppm)
-20	3.57	0.004267272	
-10	4.06	0.004852976	
0	2.85	0.003406646	
10	-3.76	-0.004494382	
20	-2.1	-0.00251016	±2.5
30	5.43	0.006490557	
40	-4.27	-0.005103992	
50	3.94	0.004709539	
Max. Deviation (ppm)	5.43	0.006490557	

Test Mode: WCDMA Band V_CH4182

Temperature vs. Frequency Stabiility

Temperature(°C)	Frequency Error (Hz)	Frequency Error (ppm)	Limit(ppm)
-20	-2.64	0.003156385	
-10	1.87	0.002235772	
0	-0.56	0.000669536	
10	3.05	0.003646581	
20	1.27	0.001518412	±2.5
30	3.62	0.004328073	
40	4.82	0.005762793	
50	2.45	0.002929220	
Max. Deviation (ppm)	4.82	0.005762793	





Test Mode: LTE Band 5_CH20525_3M

Temperature vs. Frequency Stabiility

Temperature(°C)	Frequency Error (Hz)	Frequency Error (ppm)	Limit(ppm)
-20	3.84	0.005485714	
-10	-3.21	-0.00458571	
0	-1.50	-0.00214286	
10	1.45	0.002071429	
20	-2.49	-0.00355714	± 2.5
30	5.23	0.007471429	
40	2.74	0.003914286	
50	-0.85	-0.00121429	
Max. Deviation (ppm)	5.23	0.007471429	

End of Test Report